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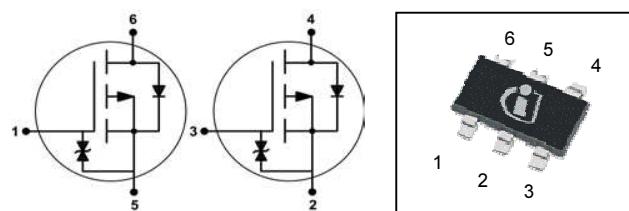
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

OptiMOS™ P3 Small-Signal-Transistor
Features

- Dual P-channel
- Enhancement mode
- Logic level (4.5V rated)
- ESD protected
- Qualified according to AEC Q101
- 100% Lead-free; RoHS compliant


Product Summary

V_{DS}	-30	V
$R_{DS(on),max}$	$V_{GS}=-10\text{ V}$	80
	$V_{GS}=-4.5\text{ V}$	130
I_D	-2.0	A



Type	Package	Tape and Reel Information	Marking	Lead Free	Packing
BSL308PE	PG-TSOP-6	L6327: 3000 pcs/ reel	sPR	Yes	Non dry

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter ¹⁾	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_A=25\text{ °C}$	-2.0	A
		$T_A=70\text{ °C}$	-1.6	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ °C}$	-8.0	
Avalanche energy, single pulse	E_{AS}	$I_D=-2\text{ A}, R_{GS}=25\text{ }\Omega$	-10.7	mJ
Reverse diode dv/dt	dv/dt	$I_D=-2\text{ A}, V_{DS}=-16\text{ V}, di/dt=-200\text{ A}/\mu\text{s}, T_{j,max}=150\text{ °C}$	6	kV/ μs
Gate source voltage	V_{GS}		± 20	V
Power dissipation ²⁾	P_{tot}	$T_A=25\text{ °C}$	0.5	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
ESD Class		JESD22-A114 -HBM	2 (2kV to 4kV)	
Soldering Temperature			260 °C	°C
IEC climatic category; DIN IEC 68-1			55/150/56	°C

¹⁾ Only one of both transistors in operation

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - ambient	R_{thJA}	minimal footprint ²⁾	-	-	250	K/W
Electrical characteristics , at $T_j=25^\circ\text{C}$, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=-250\mu\text{A}$	-30	-	-	V
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=-11\mu\text{A}$	-2.0	-1.5	-1.0	
Drain-source leakage current	I_{DSS}	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}, T_j=25^\circ\text{C}$	-	-	-1	μA
		$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}, T_j=150^\circ\text{C}$	-	-	-100	
Gate-source leakage current	I_{GSS}	$V_{\text{GS}}=-20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	-5	μA
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=-4.5\text{ V}, I_D=-1.7\text{ A}$	-	88	130	$\text{m}\Omega$
		$V_{\text{GS}}=-10\text{ V}, I_D=-2\text{ A}$	-	62	80	
Transconductance	g_{fs}	$ V_{\text{DS}} >2 I_D R_{\text{DS}(\text{on})\text{max}}, I_D=-1.6\text{ A}$		4.6	-	S

²⁾ Performed on 40mm² FR4 PCB. The traces are 1mm wide, 70µm thick and 20mm long; they are present on both sides of the PCB.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0 \text{ V}$, $V_{DS}=-15 \text{ V}$, $f=1 \text{ MHz}$	-	376	500	pF
Output capacitance	C_{oss}		-	196	261	
Reverse transfer capacitance	C_{rss}		-	12	18	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-15 \text{ V}$, $V_{GS}=-10 \text{ V}$, $I_D=-2 \text{ A}$, $R_G=6 \Omega$	-	5.6	-	ns
Rise time	t_r		-	7.7	-	
Turn-off delay time	$t_{d(off)}$		-	15.3	-	
Fall time	t_f		-	2.8	-	

Gate Charge Characteristics

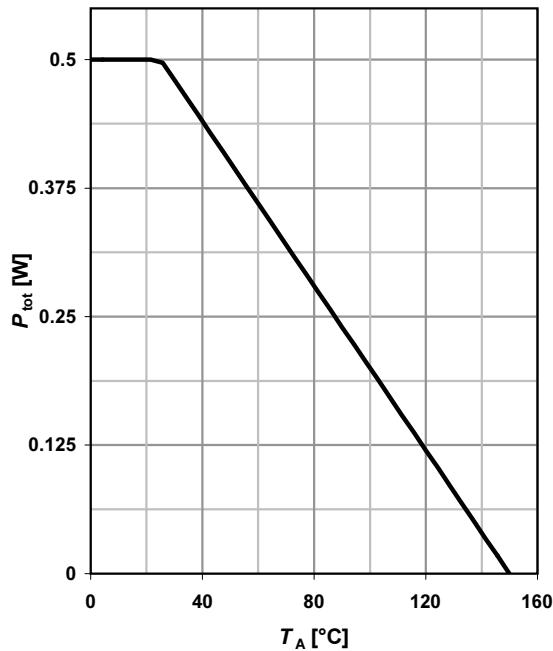
Gate to source charge	Q_{gs}	$V_{DD}=-15 \text{ V}$, $I_D=-2 \text{ A}$, $V_{GS}=0 \text{ to } -10 \text{ V}$	-	-1.2	-	nC
Gate to drain charge	Q_{gd}		-	-0.6	-	
Gate charge total	Q_g		-	-5.0	-	
Gate plateau voltage	$V_{plateau}$		-	-3.1	-	

Reverse Diode

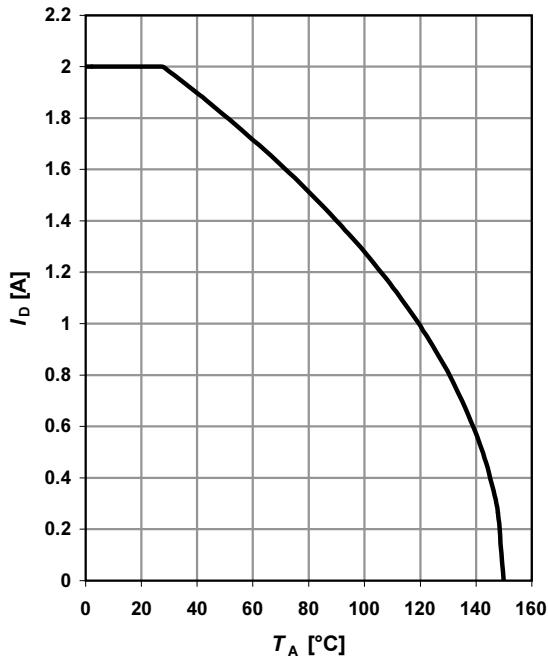
Diode continuous forward current	I_s	$T_A=25 \text{ }^\circ\text{C}$	-	-	-0.4	A
Diode pulse current	$I_{s,pulse}$		-	-	-8.4	
Diode forward voltage	V_{SD}	$V_{GS}=0 \text{ V}$, $I_F=-2 \text{ A}$, $T_j=25 \text{ }^\circ\text{C}$	-	-0.8	-1.1	V
Reverse recovery time	t_{rr}	$V_R=-10 \text{ V}$, $I_F=-2 \text{ A}$, $di_F/dt=100 \text{ A}/\mu\text{s}$	-	14	-	ns
Reverse recovery charge	Q_{rr}		-	-5.9	-	

1 Power dissipation

$$P_{\text{tot}} = f(T_A)$$

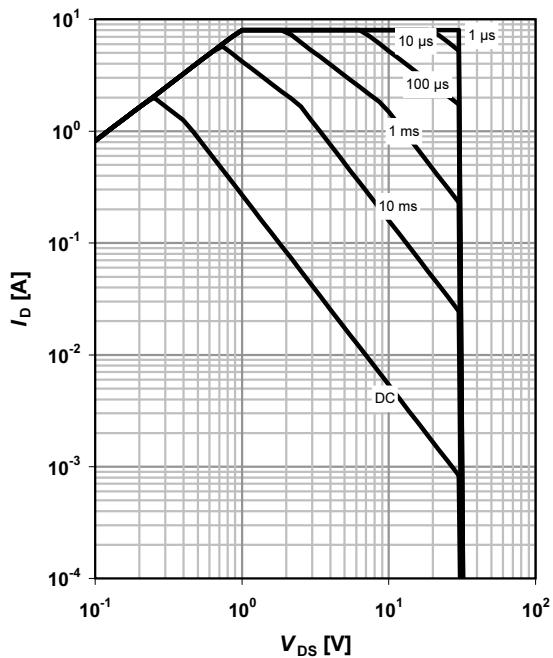

2 Drain current

$$I_D = f(T_A); V_{GS} \geq -10 \text{ V}$$


3 Safe operating area

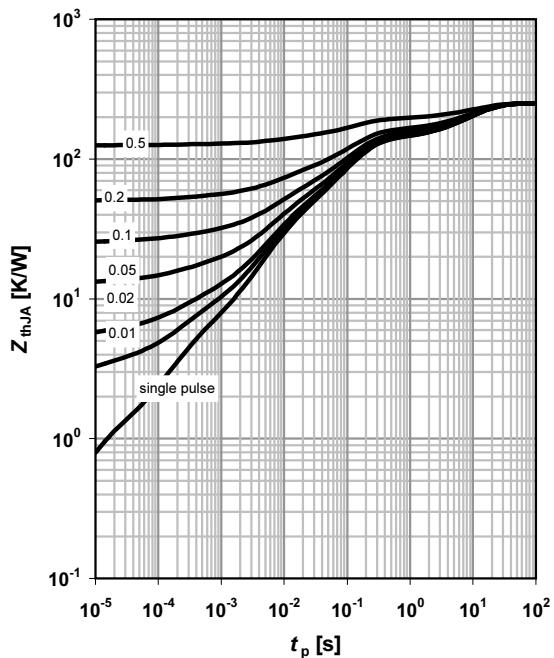
$$I_D = f(V_{DS}); T_A = 25 \text{ °C}; D = 0$$

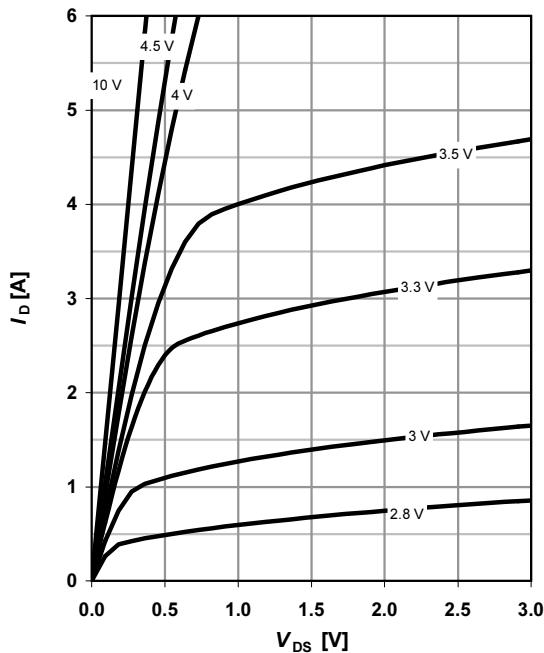
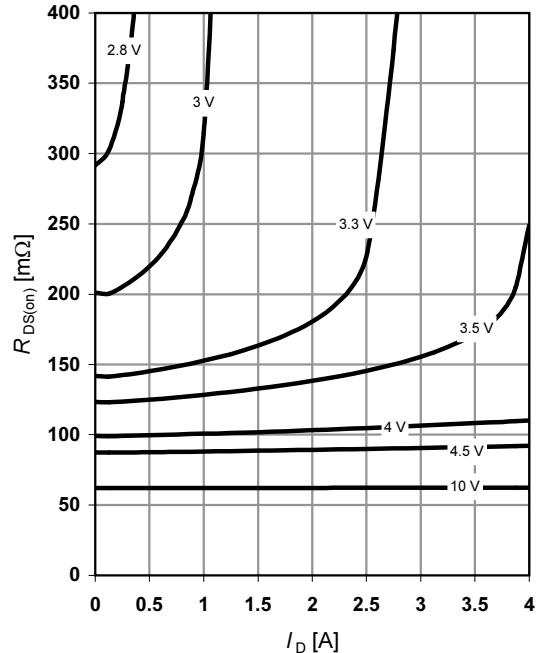
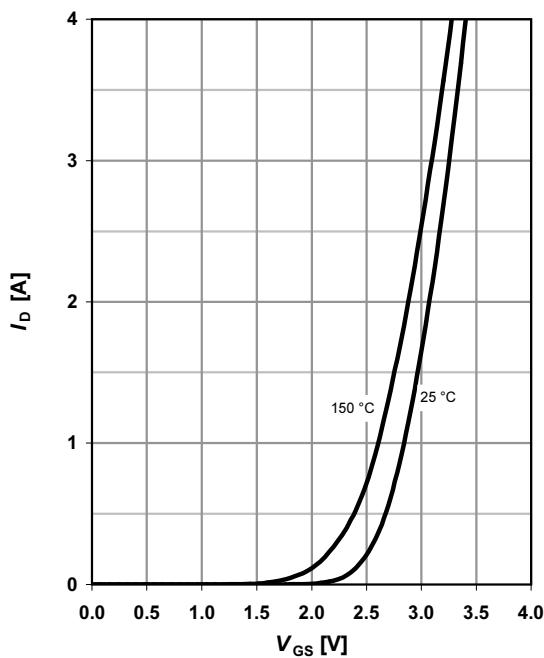
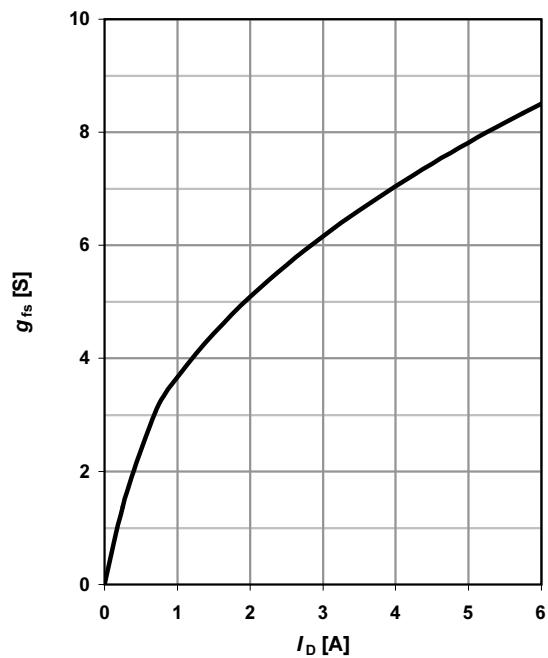
parameter: t_p

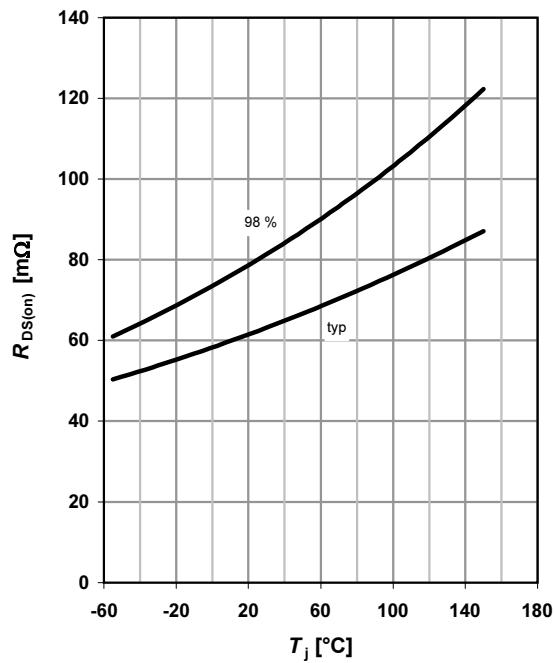

4 Max. transient thermal impedance

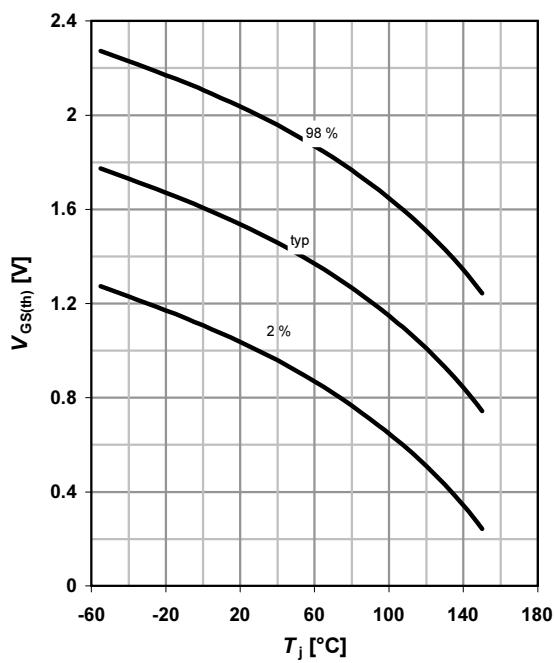
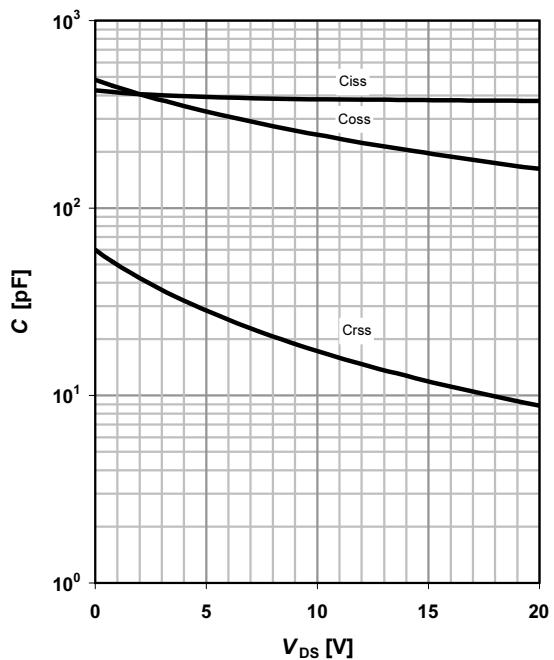
$$Z_{\text{thJA}} = f(t_p)$$

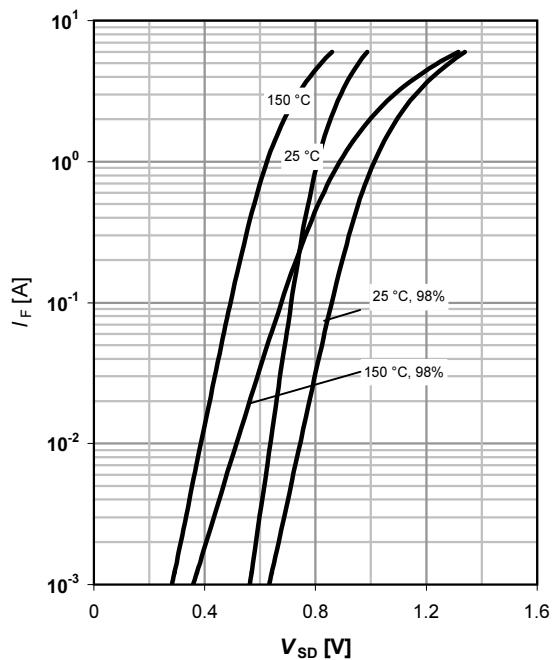
parameter: $D = t_p/T$



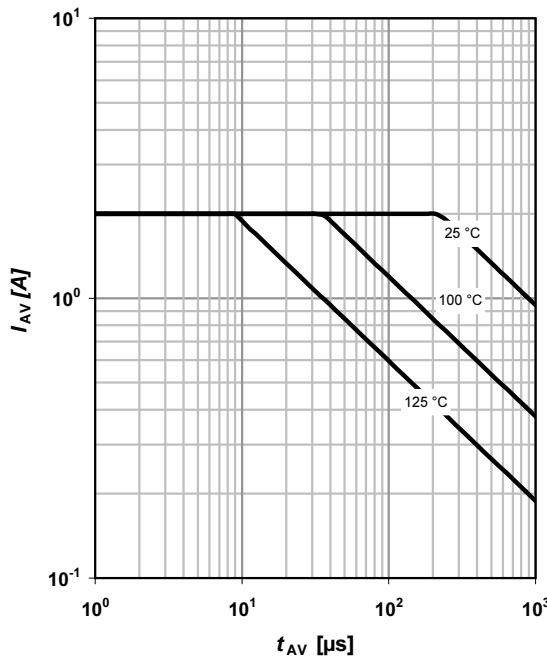
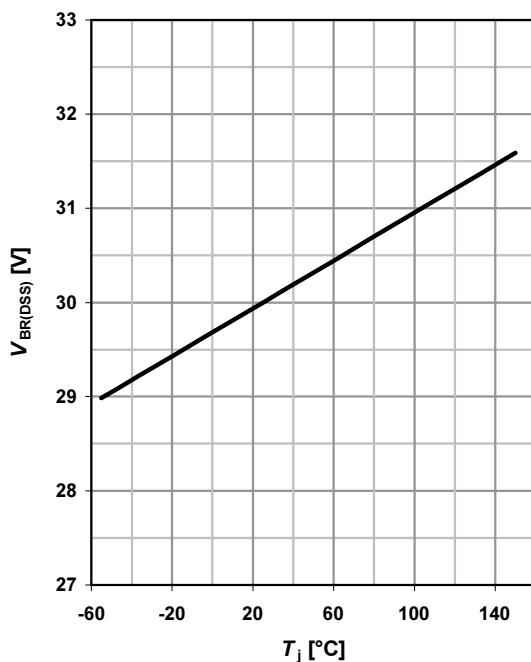
5 Typ. output characteristics
 $I_D = f(V_{DS})$; $T_j = 25^\circ\text{C}$
parameter: V_{GS} 
6 Typ. drain-source on resistance
 $R_{DS(on)} = f(I_D)$; $T_j = 25^\circ\text{C}$
parameter: V_{GS} 
7 Typ. transfer characteristics
 $I_D = f(V_{GS})$; $|V_{DS}| > 2|I_D|R_{DS(on)max}$

8 Typ. forward transconductance
 $g_{fs} = f(I_D)$; $T_j = 25^\circ\text{C}$


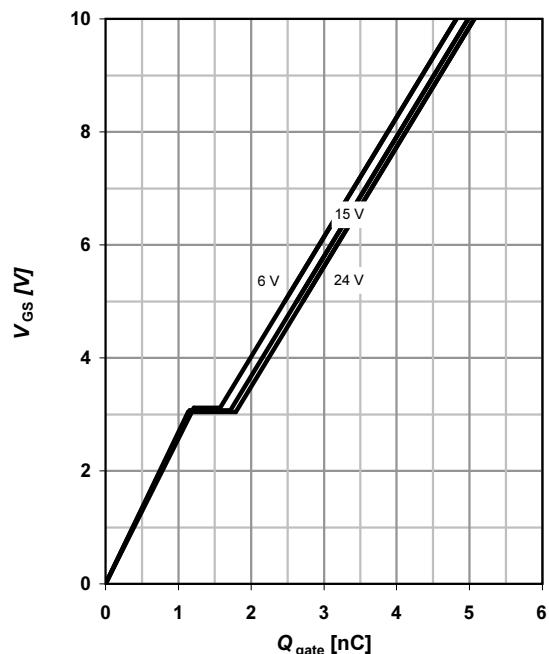
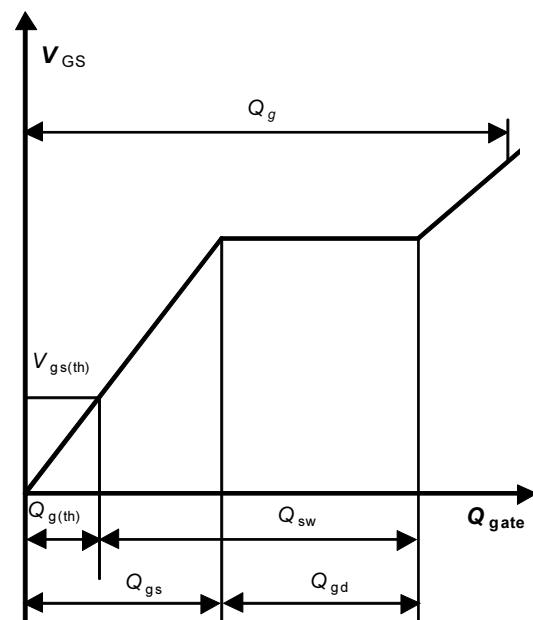
9 Drain-source on-state resistance
 $R_{DS(on)} = f(T_j); I_D = -2 \text{ A}; V_{GS} = -10 \text{ V}$

10 Typ. gate threshold voltage
 $V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = 11 \mu\text{A}$

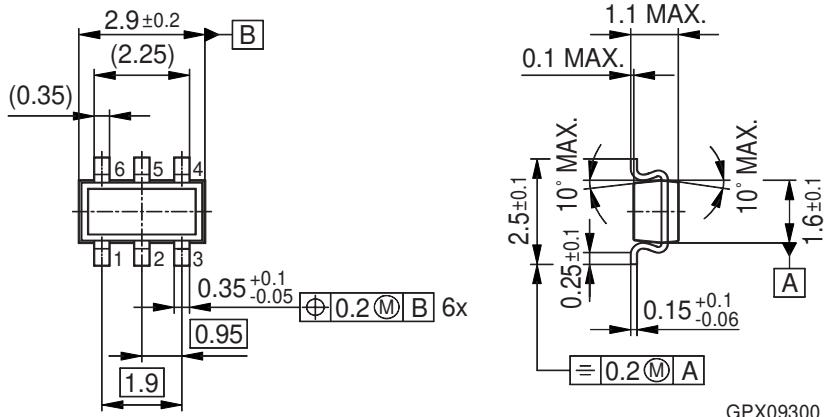
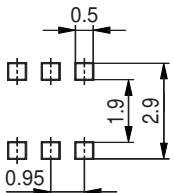
 parameter: I_D

11 Typ. capacitances
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25^\circ\text{C}$

12 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$

 parameter: T_j


13 Avalanche characteristics
 $I_{AV} = f(t_{AV})$; $R_{GS} = 25 \Omega$

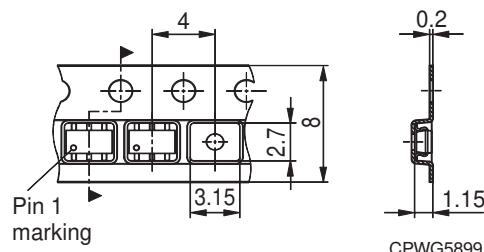
parameter: $T_{j(\text{start})}$

15 Drain-source breakdown voltage
 $V_{BR(DSS)} = f(T_j)$; $I_D = 250 \mu\text{A}$

14 Typ. gate charge
 $V_{GS} = f(Q_{\text{gate}})$; $I_D = -2 \text{ A pulsed}$

parameter: V_{DD}

16 Gate charge waveforms


TSOP-6
Package Outline:

Footprint:


Remark: Wave soldering possible dep.
on customers process conditions

HLG09283

Packaging:




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Infineon Technologies AG
81726 Munich, Germany
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